



<b>Experiment title:</b>  X-RAY DETECTION AT MICROWAVE FREQUENCIES		<b>Experiment number:</b>  MI-944
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Following a recommendation of the ESRF Technical Advisory Board (TAB), the ESRF Management has decided to protect with a Patent the whole content of this project as well as further related extensions.

M. de Beaumont, European Patent Attorney, is in charge of extending the French Patent to all European countries, the United States of America, Canada and Japan. As long as the international patent procedure is still pending, no written report will be made available externally on this subject.

**REFERENCES :**

**Patent holder:** ESRF

**Inventors:** J. Goulon; G. Goujon; A. Rogalev; F. Wilhelm

**French Patent application :** FR N° 08/ 55566 submitted on August 13<sup>th</sup> 2008  
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**European Patent extension :** EP N° 09167546.2 submitted on: August 10<sup>th</sup> 2009  
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